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Information Disclosure Statement by Applicant		Applicant Damian Fiolka et al.	
(Use several she	ets if necessary)	Filing Date	Group Art Unit
(37 CFR §1.98(b))		November 29, 2006	2872

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	1	6483573	11/19/2002	Schuster			
	2	2009/0115989	5/7/2009	Tanaka			
	3	2009/0128796	5/21/2009	Tanaka			
	4	2010/0141921	6/10/2010	Omura			
	5	2010/0141926	6/10/2010	Omura			
	6	2010/0142051	6/10/2010	Omura			

	Foreign Patent Documents or Published Foreign Patent Applications							
Examiner	Desig.		Publication	Country or			Transla	ation
Initial	ID	Document Number	Date	Patent Office	Class	Subclass	Yes	No
	7	KR 2000-0076783	12/26/2000	KR			See 1	
	8	JP 7-142338	6/2/1995	ЈРО			Abstract only	
	9	JP 2001-135560	5/18/2001	ЈРО			X	
	10	JP 2005-108925	4/21/2005	ЈРО			Abstract only	

	Other D	ocuments (include Author, Title, Date, and Place of Publication)
Examiner	Desig.	
Initial	ID	Document
	11	Himel et al., "Design and fabrication of customized illumination patterns for low ki lithography: a diffractive approach," Optical Microlithography XIV, Christopher J. Progler, Editor, Proceedings of SPIE Vol. 4346 (2001).

Examiner Signature	Date Considered
EVAMINED: Initials citation considered. Draw line through citation if no	L